Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/606,117	CHOW, ALAN Y.
Examiner	Art Unit

Frances P. Oropeza

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	SEARCHED					
Class	Subclass	Date	Examiner			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
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